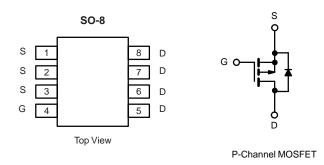


### MTP4403SQ8-VB Datasheet P-Channel 20-V (D-S) MOSFET

| PRODUCT SUMMARY     |                                    |                    |                       |  |  |
|---------------------|------------------------------------|--------------------|-----------------------|--|--|
| V <sub>DS</sub> (V) | R <sub>DS(on)</sub> (Ω)            | I <sub>D</sub> (A) | Q <sub>g</sub> (Typ.) |  |  |
|                     | 0.015 at V <sub>GS</sub> = - 4.5 V | - 13 <sup>a</sup>  |                       |  |  |
| - 20                | 0.021 at V <sub>GS</sub> = - 2.5 V | - 10 <sup>a</sup>  | 20 nC                 |  |  |
|                     | 0.040 at V <sub>GS</sub> = - 1.8 V | - 8                |                       |  |  |



#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 . Definition
- •
- Trench Power MOSFET 100 % R<sub>g</sub> Tested Compliant to RoHS Directive 2002/95/EC •



FREE

#### **APPLICATIONS**

- Portable Devices
  - Load Switch
  - Battery Switch
  - Charger Switch

| Parameter  |   | Symbol          | Limit  | Unit |  |
|--|---|-----------------|--|------|--|
| Drain-Source Voltage                               | V <sub>DS</sub>   | - 20            | V  |      |  |
| Gate-Source Voltage                                |   | V <sub>GS</sub> | ± 12   | V    |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) | $T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$ | I <sub>D</sub>  | - 13 <sup>a</sup><br>- 10 <sup>a</sup><br>- 8 <sup>b, c</sup><br>- 7,1 <sup>b, c</sup> | A    |  |
| Pulsed Drain Current                               | I <sub>DM</sub>   | - 50            | -  |      |  |
| Continuous Source-Drain Diode Current              | T <sub>C</sub> = 25 °C<br>T <sub>A</sub> = 25 °C                | ۱ <sub>S</sub>  | - 6 <sup>a</sup><br>- 2.9 <sup>b, c</sup>  |      |  |
| Maximum Power Dissipation                          | $T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$ | P <sub>D</sub>  | 19<br>12<br>3.5 <sup>b, c</sup><br>2.2 <sup>b, c</sup>                                 | W    |  |
| Operating Junction and Storage Temperature R       | T <sub>J</sub> , T <sub>stg</sub>                               | - 55 to 150     | <u></u>  |      |  |
| Soldering Recommendations (Peak Temperatur         |   | 260             |  |      |  |

| THERMAL RESISTANCE RATINGS                  |              |                   |         |         |      |  |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter                                   |              | Symbol            | Typical | Maximum | Unit |  |
| Maximum Junction-to-Ambient <sup>b, e</sup> | t ≤ 5 s      | R <sub>thJA</sub> | 28      | 36      | °C/W |  |
| Maximum Junction-to-Case (Drain)            | Steady State | R <sub>thJC</sub> | 5.3     | 6.5     | 0/11 |  |

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

e. Maximum under Steady State conditions is 80 °C/W.



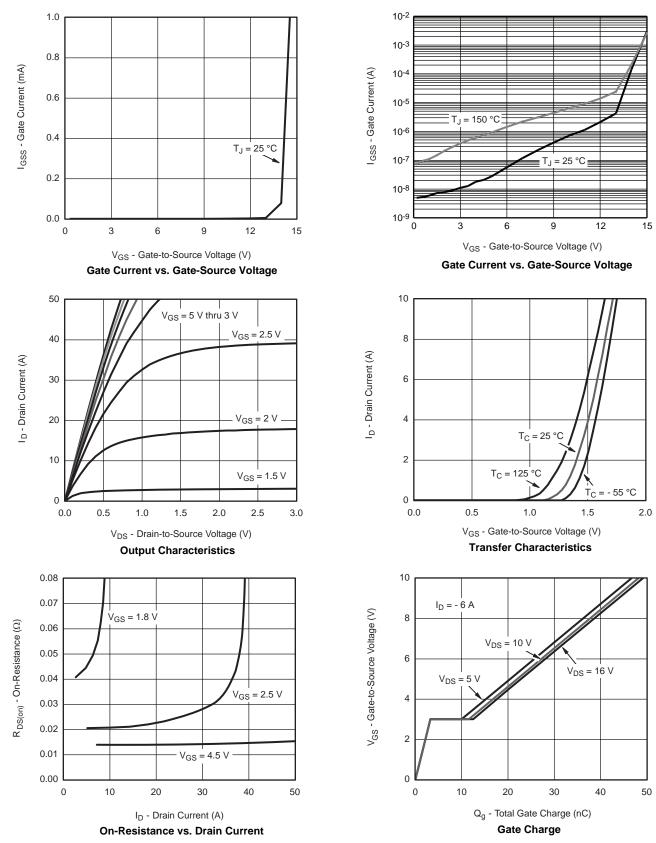
| Parameter                                     | Symbol                  | Test Conditions   | Min.  | Тур.   | Max.  | Unit  |  |
|---|-------------------------|---|-------|--------|-------|-------|--|
| Static  |                         |   |       |        | I     |       |  |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>         | $V_{GS} = 0 V, I_{D} = -250 \mu A$  | - 20  |        |       | V     |  |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$   | I <sub>D</sub> = - 250 μA   |       | - 12   |       | mV/°C |  |
| V <sub>GS(th)</sub> Temperature Coefficient   | $\Delta V_{GS(th)}/T_J$ | I <sub>D</sub> = - 250 μA   |       | 3      |       |       |  |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>     | $V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$  | - 0.5 |        | - 1.2 | V     |  |
|   | I <sub>GSS</sub>        | $V_{DS} = 0 V, V_{GS} = \pm 12 V$   |       |        | ± 20  |       |  |
| Gate-Source Leakage                           |                         | $V_{DS} = 0 V, V_{GS} = \pm 4.5 V$  |       |        | ± 0.5 |       |  |
|   |                         | $V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$  |       |        | - 1   | μΑ    |  |
| Zero Gate Voltage Drain Current               | IDSS                    | $V_{DS}$ = - 20 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C  |       |        | - 10  | 1     |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>      | $V_{DS} \leq$ - 5 V, $V_{GS}$ = - 4.5 V   | - 20  |        |       | Α     |  |
|   |                         | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5.6 A   |       | 0.015  |       | Ω     |  |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>     | V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 5.3 A   |       | 0.021  |       |       |  |
|   |                         | V <sub>GS</sub> = - 1.8 V, I <sub>D</sub> = - 2.5 A   |       | 0.040  |       |       |  |
| Forward Transconductance <sup>a</sup>         | g <sub>fs</sub>         | V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 5.6 A  |       | 35     |       | S     |  |
| Dynamic <sup>b</sup>                          |                         |   |       |        | I.    | 1     |  |
| Total Gate Charge                             |                         | V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 8 V, I <sub>D</sub> = - 5 A                       |       | 50     | 75    | 1     |  |
|   | Qg<br>Qgs<br>Qgd        |   |       | 20     | 30    | -     |  |
| Gate-Source Charge                            |                         | V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5 A                     |       | 3.3    |       |       |  |
| Gate-Drain Charge                             |                         |   |       | 8.4    |       |       |  |
| Gate Resistance                               | R <sub>g</sub>          | f = 1 MHz   | 0.2   | 1      | 2     | kΩ    |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   |       | 0.71   | 1.1   |       |  |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD}$ = - 10 V, $R_L$ = 1 $\Omega$   |       | 1.7    | 2.6   | -     |  |
| Turn-Off Delay Time                           |                         | $I_D \cong$ - 5 Å, $V_{GEN}$ = - 4.5 V, $R_g$ = 1   |       | 6      | 9     |       |  |
| Fall Time                                     | t <sub>f</sub>          | Ω   |       | 3.2    | 5     |       |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   |       | 0.3    | 0.45  | us    |  |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD}$ = - 10 V, $R_L$ = 1 $\Omega$   |       | 0.6    | 0.9   | -     |  |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_{D} \cong -5 \text{ A}, V_{GEN} = -10 \text{ V}, \text{ R}_{g} = 1$                          |       | 10     | 15    |       |  |
| Fall Time                                     | t <sub>f</sub>          | Ω   |       | 3.5    | 5.5   | 1     |  |
| Drain-Source Body Diode Characterist          |                         |   |       | L      | L     |       |  |
| Continuous Source-Drain Diode Current         | ۱ <sub>S</sub>          | T <sub>C</sub> = 25 °C  |       |        | - 6   |       |  |
| Pulse Diode Forward Current                   | I <sub>SM</sub>         |   |       |        | - 50  | A     |  |
| Body Diode Voltage                            | V <sub>SD</sub>         | $I_{S} = -5 \text{ A}, V_{GS} = 0 \text{ V}$  |       | - 0.85 | - 1.2 | V     |  |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>         |   |       | 30     | 60    | ns    |  |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>         |   |       | 20     | 40    | nC    |  |
| Reverse Recovery Fall Time                    | t <sub>a</sub>          | $I_F = 6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$ |       | 13     |       | ns    |  |
| Reverse Recovery Rise Time                    | t <sub>b</sub>          |   |       | 17     |       |       |  |

Notes:

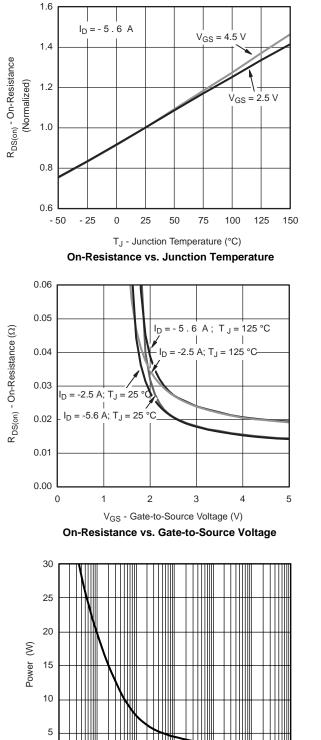
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

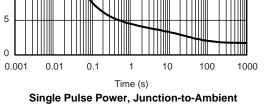
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

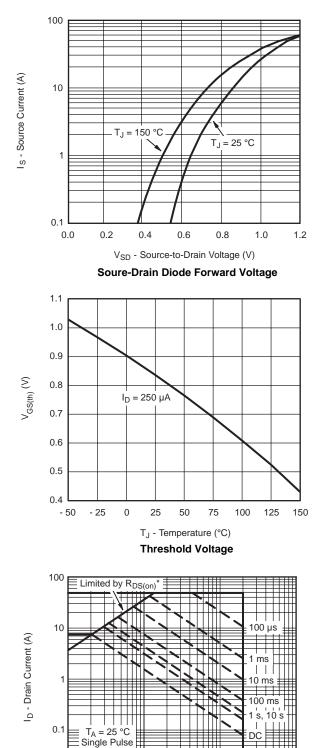




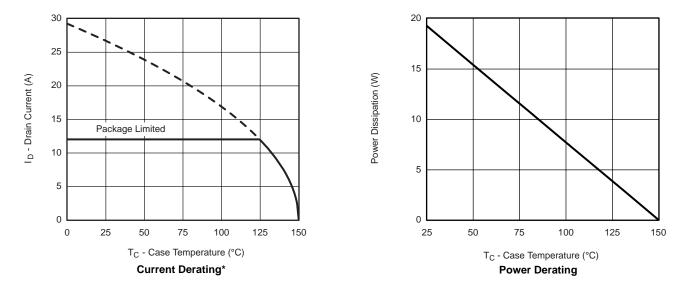






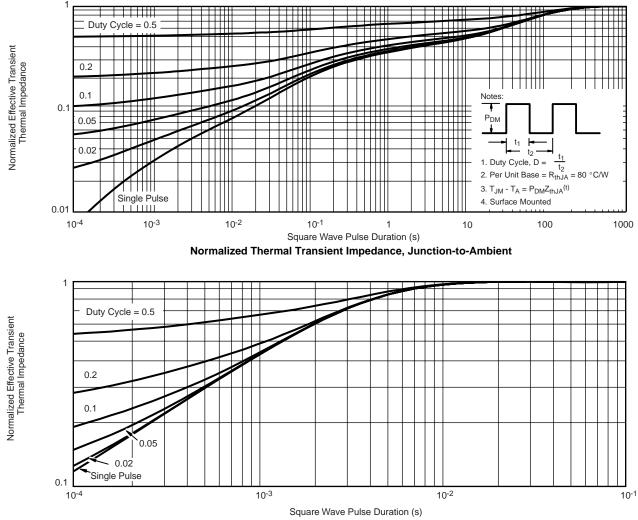






\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



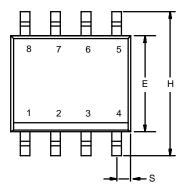


Normalized Thermal Transient Impedance, Junction-to-Case



#### SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012





|   | MILLIM | ETERS | INCHES |           |  |  |
|---|--------|-------|--------|-----------|--|--|
| DIM   | Min    | Мах   | Min    | Max       |  |  |
| A   | 1.35   | 1.75  | 0.053  | 0.069     |  |  |
| A <sub>1</sub>                              | 0.10   | 0.20  | 0.004  | 0.008     |  |  |
| В   | 0.35   | 0.51  | 0.014  | 0.020     |  |  |
| С   | 0.19   | 0.25  | 0.0075 | 0.010     |  |  |
| D   | 4.80   | 5.00  | 0.189  | 0.196     |  |  |
| E   | 3.80   | 4.00  | 0.150  | 0.157     |  |  |
| е   | 1.27   | BSC   | 0.050  | 0.050 BSC |  |  |
| н   | 5.80   | 6.20  | 0.228  | 0.244     |  |  |
| h   | 0.25   | 0.50  | 0.010  | 0.020     |  |  |
| L   | 0.50   | 0.93  | 0.020  | 0.037     |  |  |
| q   | 0°     | 8°    | 0°     | 8°        |  |  |
| S   | 0.44   | 0.64  | 0.018  | 0.026     |  |  |
| ECN: C-06527-Rev. I, 11-Sep-06<br>DWG: 5498 |        |       |        |           |  |  |



**RECOMMENDED MINIMUM PADS FOR SO-8** 



Recommended Minimum Pads Dimensions in Inches/(mm)



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